

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination MIYABE ET AL.	
			Examiner Tuan N. Nguyen	Art Unit 2828	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2003/0174753	09-2003	Yabuki et al.	372/50
	C	US-			
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NON-PATENT DOCUMENTS

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